Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	374	@ad<="20040102" and (257/688). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:07
L2	1021	@ad<="20040102" and (257/e21. 499).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:16
L3	22	@ad<="20040102" and (257/e23. 085).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:17
L4	54	@ad<="20040102" and (257/e25. 006).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:28
L5	438	@ad<="20040102" and (257/e21. 614).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:21
L6	6	@ad<="20040102" and (257/e23. 001).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:21
L7	6	@ad<="20040102" and (257/E23. 001).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:23
L8	467	@ad<="20040102" and (257/E23. 066).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:23
L10	1963	@ad<="20040102" and (257/e25. 013).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:29
L11	461	@ad<="20040102" and (257/e29. 022).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:28

5/16/06 9:40:33 AM
C:\Documents and Settings\tle10\My Documents\EAST\Workspaces\Packaging, Flip Chip, BGA, Solder Ball, Bonding Pad, Testing\107

L12	1196	@ad<="20040102" and (257/e25. 023).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:29
S1	2	"20040201087"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:15
S2	1	'samsung' and 'dong-ho lee'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:09
S3	85	lee-dong-ho.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:16
S4	16	lee-dong-ho.in. and 'package'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:21
S5	2145	@ad<="20040102" and (257/678). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 09:06
S6	526	@ad<="20040102" and (257/685). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 13:34
S7	1654	@ad<="20040102" and (257/686). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 08:22
S8	835	@ad<="20040102" and (257/730). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:24
S9	3376	@ad<="20040102" and (257/777-778).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:25
S10	957	@ad<="20040102" and (257/779). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:36

5/16/06 9:40:33 AM

S11	1307	@ad<="20040102" and (257/693). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:27
S13	33	@ad<="20040102" and 'stack package' and 'chip scale package' and 'ball grid array'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:49
S14	2040	@ad<="20040102" and (257/723). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 10:29
S15	1	"6376769".PN.	USPAT; USOCR	OR	ON	2005/04/21 10:29
S16	1	"6108210".PN.	USPAT; USOCR	OR	ON	2005/04/21 10:30
S17	1	"5950304".PN.	USPAT; USOCR	OR	ON	2005/04/21 10:30
S18	1	"6218731".PN.	USPAT; USOCR	OR	ON	2005/04/21 10:31
S19	1	"5793870".PN.	USPAT; USOCR	OR	ON	2005/04/21 10:32
S20	1	"5714405".PN.	USPAT; USOCR	OR	ON	2005/04/21 10:32
S22	45	@ad<="20040102" and 'chip stack' and 'chip scale package' and 'ball grid array'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:20
S23	50	@ad<="20040102" and 'chip stack' and 'CSP' and 'BGA'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 16:34
S24	0	@ad<="20040102" and 'chip stack' and 'chip scale package' and 'connecting board'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:20
S25	3	@ad<="20040102" and 'chip stack' and 'connecting board'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:20
S26	11	@ad<="20040102" and 'chip scale package' and 'connecting board'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:34

S27	10	@ad<="20040102" and 'chip scale package' and 'coupled' and 'flexible circuit board'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:42
S28	14	@ad<="20040102" and 'CSP' and 'coupled' and 'flexible circuit board'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:35
S29	672	@ad<="20040102" and (257/727). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:36
S30	643	@ad<="20040102" and 'chip scale package' and 'stack'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:42
S31	46	@ad<="20040102" and 'chip scale package' and 'connect' same 'flexible' with 'substrate'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:55
S32	1	"6376769".PN.	USPAT; USOCR	OR	ON	2005/04/21 13:45
S33	1	"6218731".PN.	USPAT; USOCR	OR	ON	2005/04/21 13:46
S34	1	"5793870".PN.	USPAT; USOCR	OR	ON	2005/04/21 13:46
S35	5	Cha-Ki-Bon.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/21 13:55
S36	2	"20040245628"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 14:34
S37	6	'ye-chung'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 14:52
S42	1	@ad<="20040105" and 'tape package' and 'base substrate' with 'through hole' and 'chip' and 'encapsulant' and 'copper' same 'test pad'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 14:58

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S43	1	@ad<="20040105" and 'tape package' and 'base substrate' with 'through hole' and 'chip' and 'copper' same 'test pad'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 14:58
S44	2	@ad<="20040105" and 'tape package' and 'base substrate' with 'hole' and 'chip' and 'copper' same 'test pad'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 14:59
S45	2	@ad<="20040105" and 'tape package' and 'base substrate' with 'hole' and 'chip' and 'copper'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 14:59
S46	33	@ad<="20040105" and 'tape package' and 'substrate' with 'hole' and 'chip' and 'copper'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:05
S47	1	@ad<="20040105" and 'flexible' with 'tape package' and 'through hole' and 'copper' and 'test'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:06
S48	2	@ad<="20040105" and 'flexible' with 'tape package' and 'through hole' and 'copper'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:07
S49	2	@ad<="20040105" and 'flexible' with 'tape package' and 'through hole'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:08
S50	15	@ad<="20040105" and 'flexible' with 'tape package'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:10
S51	410	@ad<="20040105" and 'LCD' with 'tape' with 'package'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:53
S52	76	@ad<="20040105" and 'flexible' with 'tape' with 'package' and 'through-hole'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:52
S53	5	@ad<="20040105" and 'flexible' with 'tape' with 'package' and 'through-hole' and 'test pad'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:11

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S54	204	@ad<="20040105" and 'tape' with 'package' and 'through-hole' and 'test'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:14
S55	34	@ad<="20040105" and 'tape' with 'package' and 'through-hole' and 'test pad'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:14
S56	2	@ad<="20040105" and 'LCD' with 'package' and 'bending slit'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:36
S57	2	"20020162626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:40
S58	21	'mori yoichi' and 'nec'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:47
S59	456	@ad<="20040105" and 'flexible' with 'tape' with 'package' and 'through' with 'hole'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:53
S60	72	@ad<="20040105" and 'LCD' with 'tape' with 'package' and 'through' with 'hole'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:58
S61	3	@ad<="20040105" and 'LCD' and 'tape' with 'package' and 'through hole' and 'test pad'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/10 15:58
S62	2	@ad<="20040102" and 'chip stack' and 'CSP' and 'MCP'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 16:34
S63	53	@ad<="20040102" and 'chip stack' and 'CSP' and 'BGA'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 16:35
S64	46	@ad<="20040102" and 'MCP' and 'CSP' and 'BGA'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/16 08:41

S65	1	"20040100772".PN.	US-PGPUB	OR	ON	2005/09/16 08:18
S66	1	"20030230801".PN.	US-PGPUB	OR	ON	2005/09/16 08:19
S67	1	"6777819".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:19
S68	1	"6762488".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:19
S69	1	"6746894".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:19
S70	1	"6737750".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:20
S71	1	"6734552".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:20
S72	1	"6734539".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:20
S73	1	"6716676".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:20
S74	1	"6667556".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:21
S75	1	"6649448".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:21
S76	1	"6607937".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:21
S77	1	"6593648".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:21
S78	1	"6590281".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:22
S79	1	"6552423".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:22
S80	1	"6383845".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:23
S81	1	"6545366".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:23
S82	1	"6512303".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:24
S83	1	"6472741".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:24
S84	1	"6462421".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:24
S85	1	"6414381".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:25
S86	1	"6413798".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:25
S87	1	"6407456".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:26
S88	1	"6265766".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:26
S89	1	"6157080".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:26

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S90	1	"5994166".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:27
S91	1	"6157080".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:27
S92	1	"5994166".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:27
S93	1	"5744863".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:27
S94	1	"5444296".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:28
S95	1	"5222014".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:28
S96	121	@ad<="20040102" and 'MCP' and 'CSP'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/16 08:43
S97	0	@ad<="20040102" and 'stacked chip' and 'firs package substrate' and 'second package substrate'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/16 08:45
S98	9	@ad<="20040102" and 'stacked chip' and 'first package substrate' and 'second package substrate'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/16 08:45
S99	100	@ad<="20040102" and 'stacked chip' and 'package substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 13:50
S10 0	1	"6376769".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:47
S10 1	1	"6218731".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:48
S10 2	1	"5793870".PN.	USPAT; USOCR	OR	ON	2005/09/16 08:48
S10 3	2	"20040201087"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/16 10:43
S10 4	563	@ad<="20040102" and (257/685). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:37

5/16/06 9:40:33 AM
C:\Documents and Settings\tle10\My Documents\EAST\Workspaces\Packaging, Flip Chip, BGA, Solder Ball, Bonding Pad, Testing\107

S10 5	1747	@ad<="20040102" and (257/686). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/15 17:00
S10 6	284	@ad<="20040102" and (257/685). ccls. and 'stacked'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 13:43
S10 7	1094	@ad<="20040102" and (257/686). ccls. and 'stacked'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:38
S10 8	101	@ad<="20040102" and 'stacked chip' and 'package substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:04
S10 9	1	"6137164".PN.	USPAT; USOCR	OR	ON	2006/01/06 13:57
S11 0	1	"6080931".PN.	USPAT; USOCR	OR	ON	2006/01/06 13:58
S11	1	"6028365".PN.	USPAT; USOCR	OR	ON	2006/01/06 13:58
S11 2	1	"5394303".PN.	USPAT; USOCR	OR	ON	2006/01/06 13:58
S11 3	214	@ad<="20040102" and 'stacked' adj2 ('chip' or 'IC' or 'device') and 'package substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:14
S11 4	130	@ad<="20040102" and 'stacked' adj1 ('chip' or 'IC' or 'device') and 'package substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:04
S11 5	266	@ad<="20040102" and 'stacked' adj1 packag\$3 same 'substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:14
S11 6	440	@ad<="20040102" and stack\$3 adj1 packag\$3 same 'substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:15
S11 7	299	@ad<="20040102" and stack\$3 adj1 packag\$3 with 'substrates'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:15

S11 8	433	@ad<="20040102" and 'infineon' and 'stacked'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:38
S11 9	94	@ad<="20040102" and 'infineon' and 'stacked' with 'device'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/06 14:39
S12 0	37	@ad<="20040102" and 'infineon' and 'stacked' with 'element'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:13
S12 1	110	"samsung" and "MCP"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:05
S12 2	0	"samsung" and lee-dong.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:10
S12 3	181	"samsung" and dong-ho.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:10
S12 4	233	@ad<="20040102" and (257/686). ccls. and ("CSP" or "MCP")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:16
S12 5	41	"samsung" and lee.in. and "CSP"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:12
S12 6	1196	@ad<="20040102" and (257/E25. 023).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 09:46
S12 7	159	@ad<="20040102" and (257/E25. 023).ccls. and ("CSP" or "MCP")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:08
S12 8	1645	@ad<="20040102" and "chip stacked"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:10

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S12 9	1236	@ad<="20040102" and "chip stack"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:09
S13 1	37	@ad<="20040102" and 'infineon' and 'stacked' with 'element'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:13
S13 2	37	@ad<="20040102" and "infineon" and "stacked" with "element"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:13
S13 4	1084	@ad<="20040102" and (257/686). ccls. and stack\$3 and chip	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/08 10:16
S13 5	2	("6232659").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/05/09 13:12
S13 6	2202	"PCB" with circuit with trace	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 13:20
S13 7	14	@ad<="20040406" and "PCB" with circuit with trace and epoxy same plastic with insulat\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 13:46
S13 8	397	@ad<="20040406" and "PCB" with circuit with "conductive trace"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 13:59
S13 9	22	@ad<="20040406" and "PCB" with epoxy with plastic with (insulat\$3 or dielectric)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 14:02
S14 0	524	@ad<="20040406" and "PCB" same epoxy with (insulat\$3 or dielectric)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 14:56

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S14 2	374	@ad<="20040406" and "PCB" with substrate and epoxy with insulat\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 15:17
S14 3	49	@ad<="20040406" and "PCB" with substrate and epoxy with insulat\$3 and "semiconductor device" with die	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/09 15:17
S14 5	281	@ad<="20040102" and (257/686). ccls. and tape and carrier	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 08:22
S14 6	143	@ad<="20040102" and (257/686). ccls. and flexible with tape	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 08:27
S14 7	170	@ad<="20040102" and Staktek	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 08:43
S14 8	166	@ad<="20040102" and seiko and "flexible tape"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/16 08:44